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 OCT 29 2002  
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INFORMATION

Applicant: Hans-Rainer ZERFASS  
 Ser.No.: 09/888 739 Filed: June 25, 2001  
 Group: 1713 Atty.Ref.: HOG600

U.S. PATENT DOCUMENTS

Examiner	Document Number	Date	Name	Class	Sub Class	Filing Date
<i>ph</i>	AA 4 434 989	3/1984	Beyer, et al.	277	235	
<i>ph</i>	AB 6 077 592	6/2000	Azuma, et al.	428	192	
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FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Sub Class	Translation Yes No
<i>ph</i>	AJ WO90/15109	12/1990	WIPO			
<i>ph</i>	AK WO93/23459	11/1993	WIPO			
<i>ph</i>	AL WO98/12085	3/1998	WIPO	(English language abstract only)		
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EXAMINER

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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.